Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/705,899	LEE ET AL.
Examiner	Art Unit
HOAN C. NGUYEN	2871

SEARCHED				
Class	Subclass	Date	Examiner	
- · · · · ·				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
	<u></u>			

SEARCH (INCLUDING SEAR		·)
	DATE	EXMR
update search	4/20/2005	CHN
		·
· -		